

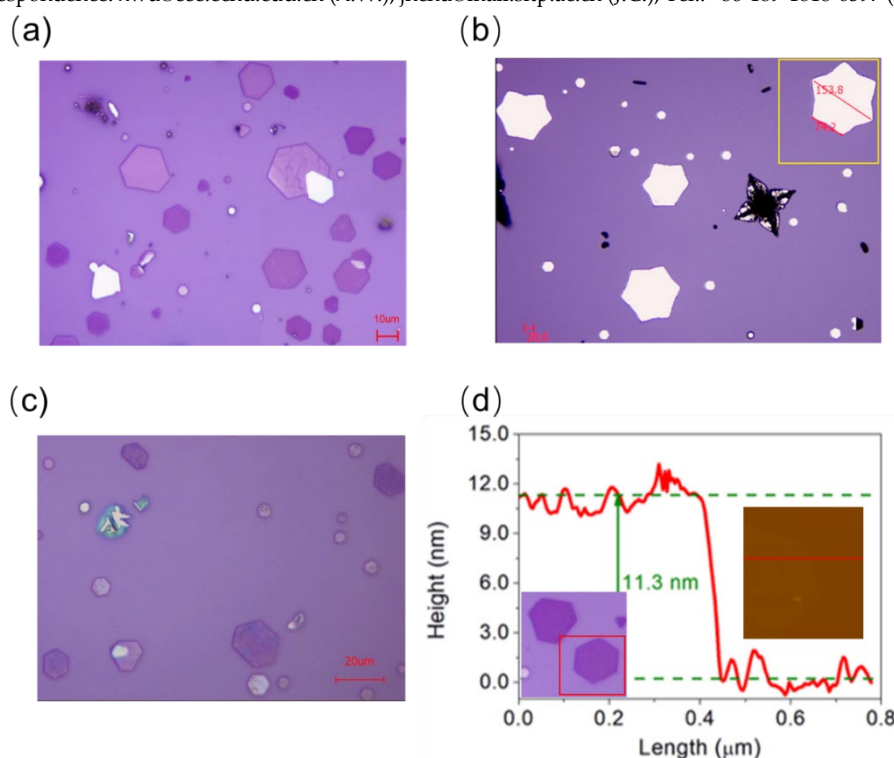
# Supplementary Materials: CVD-Grown 2D Nonlayered NiSe as a Broadband Photodetector

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**Figure S1** The optical images and AFM results of grown NiSe flakes. **(a)** The optical images of NiSe flakes with different morphologies. **(b)** The optical image of NiSe flakes with 153.8 μm. **(c)** The optical image of NiSe flakes grown one month ago. **(d)** The optical image of thinner NiSe flake and the corresponding AFM result with height profile and recognition image.

**Table S1.** The summaries of nonlayered materials-based photodetectors.

Materials	Laser wavelength (nm)	Voltage (V)	R (A/W)	D* (Jones)	Ref.
PdS	400	2	0.05	$7.81 \times 10^8$	[1]
CdTe	473	1	$0.6 \times 10^{-3}$	-	[2]
$\beta$ -In <sub>2</sub> S <sub>3</sub>	450	1	137	$4.74 \times 10^{10}$	[3]
Te	350	0.6	$1.34 \times 10^{-5}$	$3.1 \times 10^7$	[4]
Pb <sub>1-x</sub> Sn <sub>x</sub> Se	473	2	5.95	-	[5]
$\gamma$ -Ga <sub>2</sub> S <sub>3</sub>	350	1	61.3	$1.52 \times 10^{10}$	[6]
ZnSb	1550	0.5	89.2	$1.7 \times 10^{10}$	[7]
CoSe	$10.6 \times 10^3$	1	2.58	$3.3 \times 10^9$	[8]
NiSe	$10.6 \times 10^3$	0.1	6.96	$2.3 \times 10^7$	This work

## References

1. Jin, B.; Huang, P.; Zhang, Q.; Zhou, X.; Zhang, X.; Li, L.; Su, J.; Li, H.; Zhai, T., Self-Limited Epitaxial Growth of Ultrathin Nonlayered CdS Flakes for High-Performance Photodetectors. *Advanced Functional Materials* **2018**, 28, (20), 1800181.
2. Cheng, R.; Wen, Y.; Yin, L.; Wang, F.; Wang, F.; Liu, K.; Shifa, T. A.; Li, J.; Jiang, C.; Wang, Z.; He, J., Ultrathin Single-Crystalline CdTe Nanosheets Realized via Van der Waals Epitaxy. *Adv Mater* **2017**, 29, (35).
3. Huang, W.; Gan, L.; Yang, H.; Zhou, N.; Wang, R.; Wu, W.; Li, H.; Ma, Y.; Zeng, H.; Zhai, T., Controlled Synthesis of Ultrathin 2D  $\beta$ -In<sub>2</sub>S<sub>3</sub> with Broadband Photoresponse by Chemical Vapor Deposition. *Advanced Functional Materials* **2017**, 27, (36), 1702448.
4. Xie, Z.; Xing, C.; Huang, W.; Fan, T.; Li, Z.; Zhao, J.; Xiang, Y.; Guo, Z.; Li, J.; Yang, Z.; Dong, B.; Qu, J.; Fan, D.; Zhang, H., Ultrathin 2D Nonlayered Tellurium Nanosheets: Facile Liquid-Phase Exfoliation, Characterization, and Photoresponse with High Performance and Enhanced Stability. *Advanced Functional Materials* **2018**, 28, (16), 1705833.
5. Wang, Q.; Xu, K.; Wang, Z.; Wang, F.; Huang, Y.; Safdar, M.; Zhan, X.; Wang, F.; Cheng, Z.; He, J., van der Waals epitaxial ultrathin two-dimensional nonlayered semiconductor for highly efficient flexible optoelectronic devices. *Nano Lett* **2015**, 15, (2), 1183-9.
6. Zhou, N.; Gan, L.; Yang, R.; Wang, F.; Li, L.; Chen, Y.; Li, D.; Zhai, T., Nonlayered Two-Dimensional Defective Semiconductor gamma-Ga<sub>2</sub>S<sub>3</sub> toward Broadband Photodetection. *ACS Nano* **2019**, 13, (6), 6297-6307.
7. Chai, R.; Chen, Y.; Zhong, M.; Yang, H.; Yan, F.; Peng, M.; Sun, Y.; Wang, K.; Wei, Z.; Hu, W.; Liu, Q.; Lou, Z.; Shen, G., Non-layered ZnSb nanoplates for room temperature infrared polarized photodetectors. *Journal of Materials Chemistry C* **2020**, 8, (19), 6388-6395.
8. Liang, F.; Wang, C.; Luo, C.; Xia, Y.; Wang, Y.; Xu, M.; Wang, H.; Wang, T.; Zhu, Y.; Wu, P.; Ye, J.; Mu, G.; Zhu, H.; Wu, X., Ferromagnetic CoSe broadband photodetector at room temperature. *Nanotechnology* **2020**, 31, (37), 374002.